4M x 16Bit x 4 Banks Mobile SDRAM in 54BOC

FEATURES

- 3.0V & 3.3V power supply.
- · LVCMOS compatible with multiplexed address.
- · Four banks operation.
- MRS cycle with address key programs.
 - -. CAS latency (1, 2 & 3).
 - -. Burst length (1, 2, 4, 8 & Full page).
 - -. Burst type (Sequential & Interleave).
- · EMRS cycle with address key programs.
- All inputs are sampled at the positive going edge of the system clock
- Burst read single-bit write operation.
- Special Function Support.
 - -. PASR (Partial Array Self Refresh).
 - -. Internal TCSR (Temperature Compensated Self Refresh)
- · DQM for masking.
- · Auto refresh.
- 64ms refresh period (8K cycle).
- Commercial Temperature Operation (-25°C ~ 70°C).
- Extended Temperature Operation (-25°C ~ 85°C).
- 54Balls BOC with 0.8mm ball pitch

(-X:Leaded, -Z:Lead Free).

GENERAL DESCRIPTION

The K4S561633F is 268,435,456 bits synchronous high data rate Dynamic RAM organized as 4 x 4,196,304 words by 16 bits, fabricated with SAMSUNG's high performance CMOS technology. Synchronous design allows precise cycle control with the use of system clock and I/O transactions are possible on every clock cycle. Range of operating frequencies, programmable burst length and programmable latencies allow the same device to be useful for a variety of high bandwidth, high performance memory system applications.

ORDERING INFORMATION

Part No.	Part No. Max Freq.		Package
K4S561633F-X(Z)E/N/G/C/L/F75	133MHz(CL=3)		
K4S561633F-X(Z)E/N/G/C/L/F1H	105MHz(CL=2)	LVCMOS	54 BOC Leaded (Lead Free)
K4S561633F-X(Z)E/N/G/C/L/F1L	105MHz(CL=3)*1		

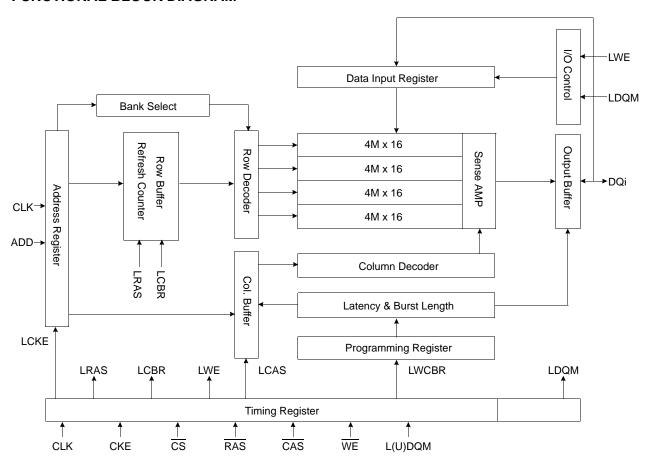
- X(Z)E/N/G: Normal / Low / Low Power, Extended Temperature(-25°C ~ 85°C)
- X(Z)C/L/F : Normal / Low / Low Power, Commercial Temperature(-25°C ~ 70°C)

NOTES:

- 1. In case of 40MHz Frequency, CL1 can be supported.
- Samsung are not designed or manufactured for use in a device or system that is used under circumstance in which human life is potentially at stake.
 Please contact to the memory marketing team in samsung electronics when considering the use of a product contained herein for any specific purpose, such as medical, aerospace, nuclear, military, vehicular or undersea repeater use.

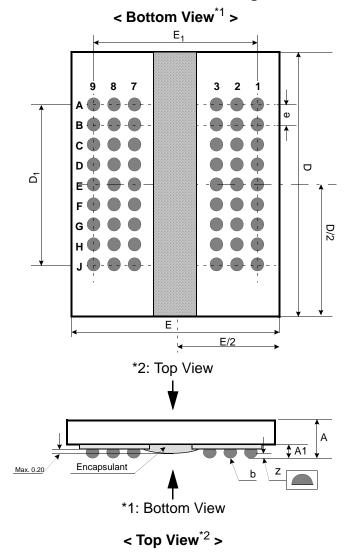


FUNCTIONAL BLOCK DIAGRAM





Package Dimension and Pin Configuration



< Top View *2 >

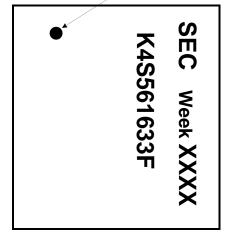
	54Ball(6x9) BOC										
	1	2	3	7	8	9					
Α	VSS	DQ15	VSSQ	VDDQ	DQ0	VDD					
В	DQ14	DQ13	VDDQ	VSSQ	DQ2	DQ1					
С	DQ12	DQ11	VSSQ	VDDQ	DQ4	DQ3					
D	DQ10	DQ9	VDDQ	VSSQ	DQ6	DQ5					
Е	DQ8	NC	VSS	VDD	LDQM	DQ7					
F	UDQM	CLK	CKE	CAS	RAS	WE					
G	A12	A11	A9	BA0	BA1	CS					
Н	A8	A7	A6	A0	A1	A10					
J	VSS	A5	A4	А3	A2	VDD					

Pin Name	Pin Function
CLK	System Clock
CS	Chip Select
CKE	Clock Enable
A0 ~ A12	Address
BA ₀ ~ BA ₁	Bank Select Address
RAS	Row Address Strobe
CAS	Column Address Strobe
WE	Write Enable
L(U)DQM	Data Input/Output Mask
DQ0 ~ 15	Data Input/Output
VDD/Vss	Power Supply/Ground
VDDQ/Vssq	Data Output Power/Ground

[Unit:mm]

Symbol	Min	Тур	Max
Α	1.00	1.10	1.20
A ₁	0.30	0.35	0.40
Е	-	8.00	-
E ₁	-	6.40	-
D	-	11.00	-
D ₁	-	6.40	-
е	-	0.80	-
b	0.45	0.50	0.55
Z	-	-	0.10





ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Voltage on any pin relative to Vss	VIN, VOUT	-1.0 ~ 4.6	V
Voltage on VDD supply relative to Vss	Vdd, Vddq	-1.0 ~ 4.6	V
Storage temperature	Тѕтс	-55 ~ + 150	°C
Power dissipation	Po	1.0	W
Short circuit current	los	50	mA

NOTES:

Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded.

Functional operation should be restricted to recommended operating condition.

Exposure to higher than recommended voltage for extended periods of time could affect device reliability.

DC OPERATING CONDITIONS

Recommended operating conditions (Voltage referenced to Vss = 0V, TA = -25 to 85°C for Extended, -25 to 70°C for Commercial)

Parameter	Symbol Min Typ Max		Unit	Note		
Supply voltage	VDD	2.7	3.0	3.6	V	
Supply voltage	VDDQ	2.7	3.0	3.6	V	
Input logic high voltage	ViH	2.2	3.0	VDDQ + 0.3	V	1
Input logic low voltage	VIL	-0.3	0	0.5	V	2
Output logic high voltage	Voн	2.4	-	-	V	Iон = -2mA
Output logic low voltage	Vol	-	-	0.4	V	IoL = 2mA
Input leakage current	lu	-10	-	10	uA	3

NOTES:

- 1. VIH (max) = 5.3V AC.The overshoot voltage duration is \leq 3ns.
- 2. VIL (min) = -2.0V AC. The undershoot voltage duration is \leq 3ns.
- 3. Any input $0V \le VIN \le VDDQ$.

Input leakage currents include Hi-Z output leakage for all bi-directional buffers with tri-state outputs.

$\textbf{CAPACITANCE} \text{ (VDD = 3.0V, TA = 23°C, f = 1MHz, VREF =0.9V $\pm 50 \text{ mV)}}$

Pin	Symbol	Min	Max	Unit	Note
Clock	Ссік	2.0	4.0	pF	
RAS, CAS, WE, CS, CKE, DQM	CIN	2.0	4.0	pF	
Address	CADD	2.0	4.0	pF	
DQ0 ~ DQ15	Соит	3.5	6.0	pF	



^{4.} Dout is disabled, $0V \le VOUT \le VDDQ$.

DC CHARACTERISTICS

Recommended operating conditions (Voltage referenced to Vss = 0V, TA = -25 to $85^{\circ}C$ for Extended, -25 to $70^{\circ}C$ for Commercial)

		_				Versio	n		N
Parameter	Symbol	Te	est Cond	lition	-75	-1H	-1L	Unit	Note
Operating Current (One Bank Active)	Icc1	Burst length = 1 tRC ≥ tRC(min) lo = 0 mA	$s \ge tRC(min)$ 90 8				85	mA	1
Precharge Standby Current in	Icc2P	CKE ≤ VIL(max), t	cc = 10n	s		0.5	mA		
power-down mode	Icc2PS	CKE & CLK ≤ VIL(max), tco	0 = ∞		0.5		IIIA	
Precharge Standby Current	Icc2N	CKE ≥ VIH(min), C Input signals are o		min), tcc = 10ns one time during 20ns		15		mA	
in non power-down mode	Icc2NS	CKE ≥ VIH(min), C Input signals are s	CLK ≤ Vı∟ stable	(max), $tcc = \infty$		10		IIIA	
Active Standby Current	ІссзР	CKE ≤ VIL(max), to	cc = 10n	S		6	mA		
in power-down mode	Icc3PS	CKE & CLK ≤ VIL(max), tco	$C = \infty$	6			IIIA	
Active Standby Current in non power-down mode	ІссзN	CKE ≥ VIH(min), C Input signals are o		min), tcc = 10ns one time during 20ns	25			mA	
(One Bank Active)	Icc3NS	CKE \geq VIH(min), CLK \leq VIL(max), tcc = ∞ Input signals are stable				25			
Operating Current (Burst Mode)	Icc4	Io = 0 mA Page burst 4Banks Activated tccd = 2CLKs	I		130	130	105	mA	1
Refresh Current	Icc5	trc ≥ trc(min)			185	185	165	mA	2
				-E/C	1500				4
				-N/L		800		uA	5
Colf Defrach Current	loof	CKE < 0.0)/		Internal TCSR	Max 4	40 M	Max 85/70		3
Self Refresh Current	Icc6	CKE ≤ 0.2V	-G/F	Full Array	550 800		800		
			-0/1	1/2 of Full Array	450 60		600	uA	6
				1/4 of Full Array 400		400 470			

NOTES:

- 1. Measured with outputs open.
- 2. Refresh period is 64ms.
- 3. Internal TCSR can be supported.

In commercial Temp : Max 40° C/Max 70° C, In extended Temp : Max 40° C/Max 85° C

- 4. K4S561633F-X(Z)E/C**
- 5. K4S561633F-X(Z)N/L**
- 6. K4S561633F-X(Z)G/F**
- 7. Unless otherwise noted, input swing level is CMOS(VIH /VIL=VDDQ/VSSQ).



AC OPERATING TEST CONDITIONS (VDD = 2.7V ~ 3.6V, TA = -25 to 85°C for Extended, -25 to 70°C for Commercial)

Parameter	Value	Unit
AC input levels (Vih/Vil)	2.4 / 0.4	V
Input timing measurement reference level	0.5 x Vddq	V
Input rise and fall time	tr/tf = 1/1	ns
Output timing measurement reference level	0.5 x Vddq	V
Output load condition	See Figure 2	

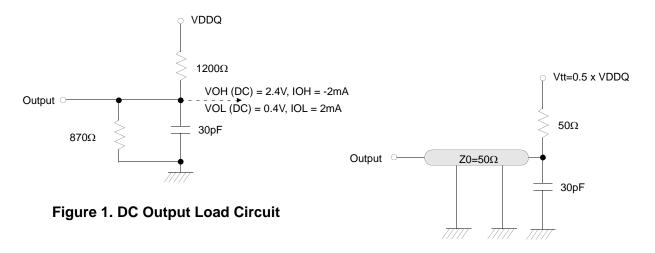


Figure 2. AC Output Load Circuit

OPERATING AC PARAMETER

(AC operating conditions unless otherwise noted)

Parameter		Symbol		Version		Unit	Note
Faranietei		Symbol	-75	-1H	-1L	Onit	Note
Row active to row active delay		trrd(min)	15	19	19	ns	1
RAS to CAS delay		trcd(min)	19	19	24	ns	1
Row precharge time		trp(min)	19	19	24	ns	1
Row active time		tras(min)	45	50	60	ns	1
		tras(max)	100			us	
Row cycle time		trc(min)	64	69	84	ns	1
Last data in to row precharge		trdl(min)	2			CLK	2
Last data in to Active delay		tDAL(min)		tRDL + tRP	-	3	
Last data in to new col. address	delay	tcdl(min)	1			CLK	2
Last data in to burst stop		tBDL(min)		1			2
Col. address to col. address de	lay	tccd(min)		1			4
Number of valid output data	CAS latency=3			2			
Number of valid output data	CAS latency=2			1	ea	5	
Number of valid output data	(CAS latency=1		0			

NOTES:



^{1.} The minimum number of clock cycles is determined by dividing the minimum time required with clock cycle time and then rounding off to the next higher integer.

^{2.} Minimum delay is required to complete write.

^{3.} Minimum tRDL=2CLK and tDAL(= tRDL + tRP) is required to complete both of last data write command(tRDL) and precharge command(tRP).

^{4.} All parts allow every cycle column address change.

^{5.} In case of row precharge interrupt, auto precharge and read burst stop.

AC CHARACTERISTICS (AC operating conditions unless otherwise noted)

Paramete		Sumb al	-7	75		IH.		1L	Unit	Note
Paramete		Symbol	Min	Max	Min	Max	Min	Max	Unit	Note
CLK cycle time	CAS latency=3	tcc	7.5		9.5		9.5			
CLK cycle time	CAS latency=2	tcc	9.5	1000	9.5	1000	12	1000	ns	1
CLK cycle time	CAS latency=1	tcc	-		-		25			
CLK to valid output delay	CAS latency=3	tsac		5.4		7		7		
CLK to valid output delay	CAS latency=2	tsac		7		7		8	ns	1,2
CLK to valid output delay	CAS latency=1	tsac		-		-		20		
Output data hold time	CAS latency=3	tон	2.5		2.5		2.5			
Output data hold time	CAS latency=2	tон	2.5		2.5		2.5		ns	2
Output data hold time	CAS latency=1	tон	-		-		2.5			
CLK high pulse width		tсн	2.5		3.0		3.0		ns	3
CLK low pulse width		tcL	2.5		3.0		3.0		ns	3
Input setup time		tss	2.0		2.5		2.5		ns	3
Input hold time		tsн	1.0		1.5		1.5		ns	3
CLK to output in Low-Z		tslz	1		1		1		ns	2
	CAS latency=3			5.4		7		7		
CLK to output in Hi-Z	CAS latency=2	tsHZ		7		7		8	ns	
	CAS latency=1			-		-		20		

NOTES:

- 1. Parameters depend on programmed CAS latency.
- 2. If clock rising time is longer than 1ns, (tr/2-0.5)ns should be added to the parameter.
- 3. Assumed input rise and fall time (tr & tf) = 1ns.

If tr & tf is longer than 1ns, transient time compensation should be considered,

i.e., [(tr + tf)/2-1]ns should be added to the parameter.



SIMPLIFIED TRUTH TABLE

C	OMMAND		CKEn-1	CKEn	cs	RAS	CAS	WE	DQM	BA0,1	A10/AP	A12, A11 A9 ~ A0	Note
Register	Mode Regis	ster Set	Н	Х	L	L	L	L	Х		OP CO	DE	1, 2
	Auto Refres	sh	Н	Н	L	L	L	Н	х		Х		3
Pefresh	Refresh Self	Entry	11	L	_	_	_	''	^		^		3
ivellesii		Exit	L	Н	L	Н	Н	Н	Х		Х		3
1.666	LXII	_	'''	Н	Х	Х	Х	^		^		3	
Bank Active & Ro	ow Addr.		Н	Х	L	L	Н	Н	Х	V	Row A	Address	
Read &		arge Disable	Н	Х						V	L	Column	4
Column Address	Auto Precha	arge Enable	П	Χ	L	Н	L	Н	Х	V	Н	Address (A0~A8)	4, 5
Write &	Auto Precha	arge Disable	Н	Х		Н	L		Х	V	L	Column	4
Column Address Auto Precharg		arge Enable	П	^	L	Н	_	L	^	V	Н	Address (A0~A8)	4, 5
Burst Stop			Н	Х	L	Н	Н	L	Х		Х		6
Precharge	Bank Select	tion	Н	Х	L	L	Н	L	Х	V	L	Х	
Frecharge	All Banks		11	^	_		"	_	^	Х	Н	^	
		Entry	Н	L	Н	Х	Х	Х	Х				
Clock Suspend o		Litty	""	L	L	V	V	V	^		Х		
		Exit	L	Н	Χ	Х	Х	Х	Х				
		Entry	Н	L	Н	Х	Х	Х	х				
Precharge Power	r Down	Entry	П	_	L	Н	Н	Н	^		Х		
Mode		Exit	L	Н	Н	Х	Х	Х	Х		^		
EXIT		EXIL	L	П	L	V	V	V	^				
DQM		•	Н			Х	•		V		Х		7
No Operation Co	mmand		Н	Х	Н	Х	Х	Х	Х		Х		
TNO Operation Co	minanu		П	^	L	Н	Н	Н	X		X		

(V=Valid, X=Don't Care, H=Logic High, L=Logic Low)

NOTES:

1. OP Code: Operand Code

A0 ~ A12 & BA0 ~ BA1 : Program keys. (@MRS)

MRS can be issued only at all banks precharge state.A new command can be issued after 2 CLK cycles of MRS.

3. Auto refresh functions are the same as CBR refresh of DRAM.

The automatical precharge without row precharge command is meant by "Auto".

Auto/self refresh can be issued only at all banks precharge state.

Partial self refresh can be issued only after setting partial self refresh mode of EMRS.

- 4. BA0 ~ BA1 : Bank select addresses.
- During burst read or write with auto precharge, new read/write command can not be issued. Another bank read/write command can be issued after the end of burst.

New row active of the associated bank can be issued at tRP after the end of burst.

- 6. Burst stop command is valid at every burst length.
- 7. DQM sampled at the positive going edge of CLK masks the data-in at that same CLK in write operation (Write DQM latency is 0), but in read operation, it makes the data-out Hi-Z state after 2 CLK cycles. (Read DQM latency is 2).



A. MODE REGISTER FIELD TABLE TO PROGRAM MODES

Register Programmed with Normal MRS

Address	BA0 ~ BA1	A12~A10/AP	A9 *2	A8	A7	A6	A5	A4	А3	A2	A 1	Α0
Function	"0" Setting for Normal MRS	RFU ^{*1}	W.B.L	Test I	Mode	CA	AS Later	псу	ВТ	Bu	ırst Lenç	gth

Normal MRS Mode

	-	Test Mode		CA	S Late	ency		Burst	Туре	Burst Length						
A8	A7	Туре	A6	A5	A4	Latency	А3	-	Туре	A2	A 1	A0	BT=0	BT=1		
0	0	Mode Register Set	0	0	0	Reserved	0	Sequential		0	0	0	1	1		
0	1	Reserved	0	0	1	1	1	1 Interleav		0	0	1	2	2		
1	0	Reserved	0	1	0	2	Mode Select			0	1	0	4	4		
1	1	Reserved	0	1	1	3	BA1	BA0	Mode	0	1	1	8	8		
	Write	Burst Length	1	0	0	Reserved				1	0	0	Reserved	Reserved		
Α9		Length	1	0	1	Reserved	0	0	Setting for Nor-	1	0	1	Reserved	Reserved		
0		Burst	1	1	0	Reserved		J	mal MRS	1	1	0	Reserved	Reserved		
1		Single Bit	1	1	1	Reserved				1	1	1	Full Page	Reserved		

Full Page Length x16: 256Mb(512)

Register Programmed with Extended MRS

Address	BA1	BA0	A12 ~ A10/AP	A9	A8	A7	A6	A5	A4	А3	A2	A 1	A0
Function	Mode	Select		RFU*1			DS		RFU ^{*1}		PASR		

EMRS for PASR(Partial Array Self Ref.) & DS(Driver Strength)

	ı	Mode Select				Driv	er Stre	ength	PASR						
BA1	BA0		Mode	A6	A5	Driver Strength		A2	A1	Α0	Size of Refreshed Array				
0	0	No	rmal MRS		0	0	Full		0	0	0	Full Array			
0	1	R	eserved		0	1	1/2		0	0	1	1/2 of Full Array			
1	0	EMRS for	Mobile SDR	RAM	M 1		Reserved		0	1	0	1/4 of Full Array			
1	1	R	eserved		1	1	Reserved		0	1	1	Reserved			
			Reserved A	ddres	S				1	0	0	Reserved			
A12~/	A10/AP	A9	A8	Α	7	A	\4	А3	1	0	1	Reserved			
	0	0	0)	0		0	1	1	0	Reserved			
	•			`	•		•			1	1	Reserved			

1.RFU(Reserved for future use) should stay "0" during MRS cycle.
2.If A9 is high during MRS cycle, "Burst Read Single Bit Write" function will be enabled.



Partial Array Self Refresh

- 1. In order to save power consumption, Mobile SDRAM has PASR option.
- 2. Mobile SDRAM supports 3 kinds of PASR in self refresh mode: Full Array, 1/2 of Full Array, and 1/4 of Full Array.

BA1=0	BA1=0
BA0=0	BA0=1
BA1=1	BA1=1
BA0=0	BA0=1

BA1=0 BA0=0 BA0=1 BA1=1 BA0=0 BA1=1 BA0=1 BA1=0 BA0=0 BA0=1 BA1=1 BA0=0 BA1=1 BA0=1

- Full Array

- 1/2 Array

- 1/4 Array



Partial Self Refresh Area

Internal Temperature Compensated Self Refresh (TCSR)

- In order to save power consumption, Mobile-DRAM includes the internal temperature sensor and control units to control the self refresh cycle automatically according to the two temperature range: Max 40 °C and Max 85 °C(for Extended), Max 70 °C(for Commercial).
- 2. If the EMRS for external TCSR is issued by the controller, this EMRS code for TCSR ignored.

			Self Refresh	Current (Icc6)		
Temperature Range	- E/C	- N/L			Unit	
	- 6/0	- IN/L	Full Array 1/2 of Full Array 1/4 of Full Array			
Max 85/70 °C	1500	800	800	600	470	uA
Max 40 °C	1300	800	550	450	400	uA

B. POWER UP SEQUENCE

- 1. Apply power and attempt to maintain CKE at a high state and all other inputs may be undefined.
- Apply VDD before or at the same time as VDDQ.
- 2. Maintain stable power, stable clock and NOP input condition for a minimum of 200us.
- 3. Issue precharge commands for all banks of the devices.
- 4. Issue 2 or more auto-refresh commands.
- 5. Issue a mode register set command to initialize the mode register.
- 6. Issue a extended mode register set command to define DS or PASR operating type of the device after normal MRS.

EMRS cycle is not mandatory and the EMRS command needs to be issued only when DS or PASR is used.

The default state without EMRS command issued is full driver strength and full array refreshed.

The device is now ready for the operation selected by EMRS.

For operating with DS or PASR, set DS or PASR mode in EMRS setting stage.

In order to adjust another mode in the state of DS or PASR mode, additional EMRS set is required but power up sequence is not needed again at this time. In that case, all banks have to be in idle state prior to adjusting EMRS set.



C. BURST SEQUENCE

1. BURST LENGTH = 4

Initial Address			Sean	ential		Interleave						
A1	A0		Ocqu	Cittai		c.reave						
0	0	0	1	2	3	0	1	2	3			
0	1	1	2	3	0	1	0	3	2			
1	0	2	3	0	1	2	3	0	1			
1	1	3	0	1	2	3	2	1	0			

2. BURST LENGTH = 8

Init	ial Addr	ess				Soan	ential				Interleave								
A2	A1	A0				Jequ	Cilliai			intelleave									
0	0	0	0	1	2	3	4	5	6	7	0	1	2	3	4	5	6	7	
0	0	1	1	2	3	4	5	6	7	0	1	0	3	2	5	4	7	6	
0	1	0	2	3	4	5	6	7	0	1	2	3	0	1	6	7	4	5	
0	1	1	3	4	5	6	7	0	1	2	3	2	1	0	7	6	5	4	
1	0	0	4	5	6	7	0	1	2	3	4	5	6	7	0	1	2	3	
1	0	1	5	6	7	0	1	2	3	4	5	4	7	6	1	0	3	2	
1	1	0	6	7	0	1	2	3	4	5	6	7	4	5	2	3	0	1	
1	1	1	7	0	1	2	3	4	5	6	7	6	5	4	3	2	1	0	

